

Search Notes

Application/Control No.

09/534,466

Examiner

Ren L. Yan

Applicant(s)/Patent under
Reexamination

ALBERT ET AL.

Art Unit

2854

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR